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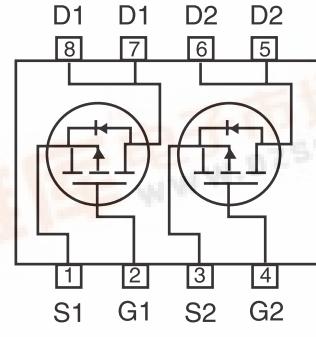
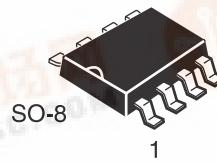
PRELIMINARY

Dual P-Channel Enhancement Mode MOSFET

FEATURES

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- -30V , -2.9A , $R_{DS(ON)}=100m\Omega$ @ $V_{GS}=-10V$.
- $R_{DS(ON)}=150m\Omega$ @ $V_{GS}=-4.5V$.
- Super high dense cell design for extremely low $R_{DS(ON)}$.
- High power and current handing capability.
- Surface Mount Package.



ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	-30	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous ^a @ $T_J=125^\circ C$ -Pulsed ^b	I_D	± 2.9	A
	I_{DM}	± 10	A
Drain-Source Diode Forward Current ^a	I_S	-1.2	A
Maximum Power Dissipation ^a	P_D	2	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	$^\circ C$

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Ambient ^a	$R_{\theta JA}$	78	$^\circ C/W$
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ELECTRICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

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Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BVDSS	V _{GS} =0V, I _D =-250μA	-30			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-24V, V _{GS} =0V			-2	μA
Gate-Body Leakage	I _{GSS}	V _{GS} =±20V, V _{DS} =0V			±100	nA
ON CHARACTERISTICS^b						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =-250μA	-1	-1.6	-3	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =-10V, I _D =-1A			100	mΩ
		V _{GS} =-4.5V, I _D =-0.5A			150	mΩ
On-State Drain Current	I _{D(ON)}	V _{DS} =-5V, V _{GS} =-10V	-10			A
Forward Transconductance	g _{FS}	V _{DS} =-15V, I _D =-2.9A	2			S
DYNAMIC CHARACTERISTICS^c						
Input Capacitance	C _{ISS}	V _{DS} =-10V, V _{GS} =0V f=1.0MHz		350	460	pF
Output Capacitance	C _{OSS}			260	340	pF
Reverse Transfer Capacitance	C _{RSS}			100	130	pF
SWITCHING CHARACTERISTICS^c						
Turn-On Delay Time	t _{D(ON)}	V _{DD} =-10V, R _L =10Ω, I _D =-1A, V _{GEN} =-10V, R _{GEN} =6Ω		12	40	ns
Rise Time	t _r			13	40	ns
Turn-Off Delay Time	t _{D(OFF)}			18	90	ns
Fall Time	t _f			7	50	ns
Total Gate Charge	Q _g	V _{DS} =-10V, I _D =-2.9A, V _{GS} =-10V		10	25	nC
Gate-Source Charge	Q _{gs}			2		nC
Gate-Drain Charge	Q _{gd}			3		nC

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ELECTRICAL CHARACTERISTICS ($T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS^b						
Diode Forward Voltage	V_{SD}	$V_{GS} = 0V, I_S = -1.25A$		-0.8	-1.3	V

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Notes

- a. Surface Mounted on FR4 Board, $t \leq 10\text{ sec}$.
- b. Pulse Test: Pulse Width $\leq 300\ \mu\text{s}$, Duty Cycle $\leq 2\%$.
- c. Guaranteed by design, not subject to production testing.

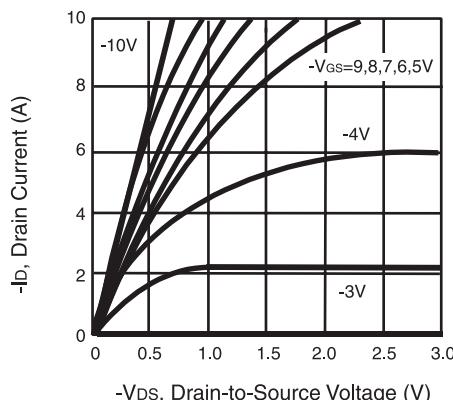


Figure 1. Output Characteristics

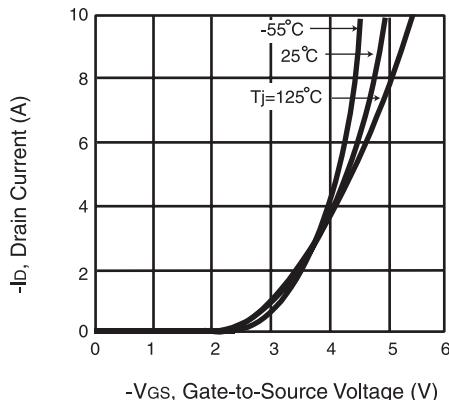


Figure 2. Transfer Characteristics

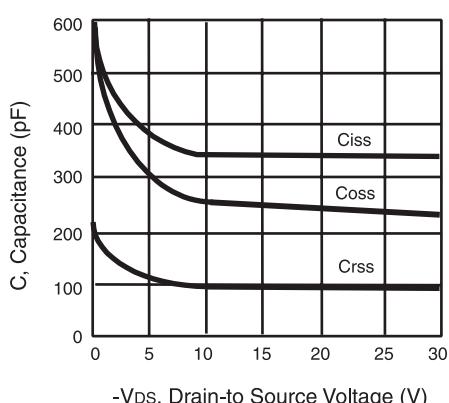


Figure 3. Capacitance

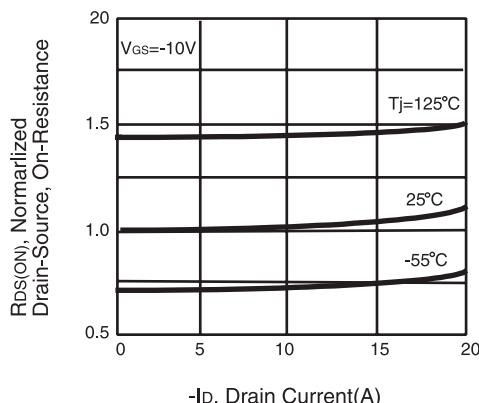
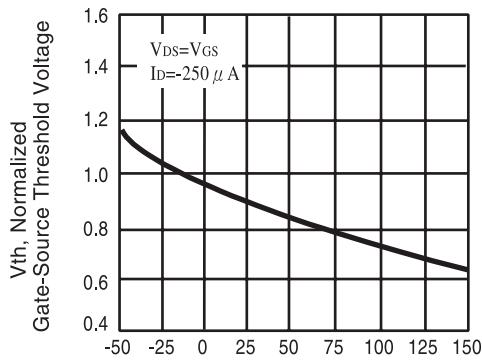


Figure 4. On-Resistance Variation with Drain Current and Temperature

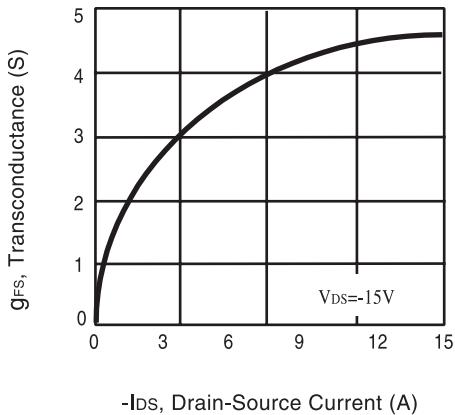
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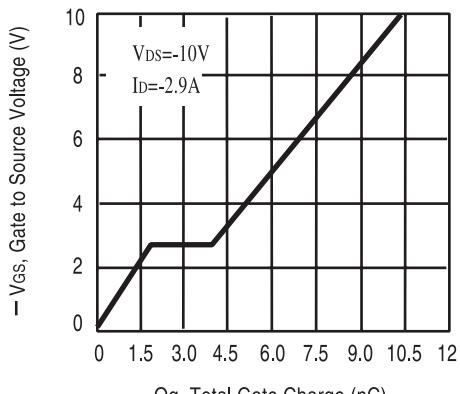
T_j , Junction Temperature (°C)

Figure 5. Gate Threshold Variation with Temperature



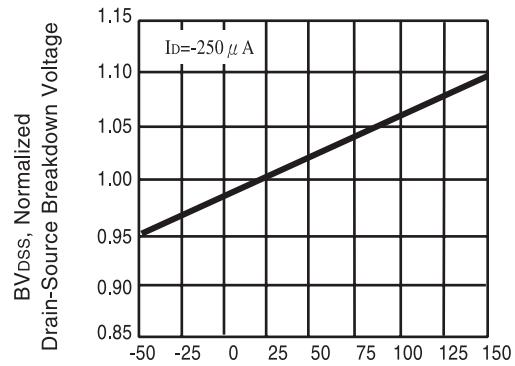
$-I_{ds}$, Drain-Source Current (A)

Figure 7. Transconductance Variation with Drain Current



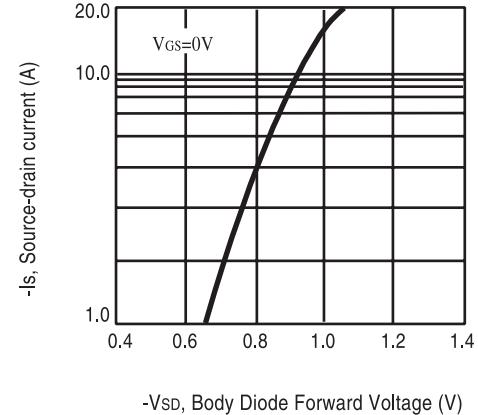
Q_g , Total Gate Charge (nC)

Figure 9. Gate Charge



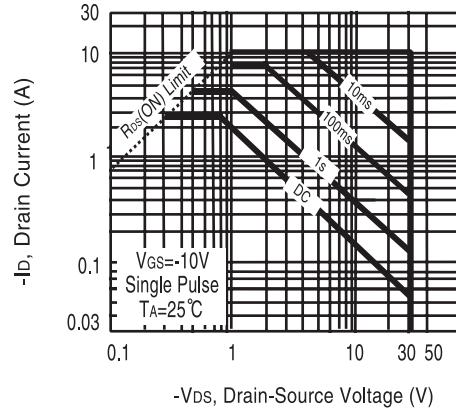
T_j , Junction Temperature (°C)

Figure 6. Breakdown Voltage Variation with Temperature



$-V_{sd}$, Body Diode Forward Voltage (V)

Figure 8. Body Diode Forward Voltage Variation with Source Current



$-V_{ds}$, Drain-Source Voltage (V)

Figure 10. Maximum Safe Operating Area

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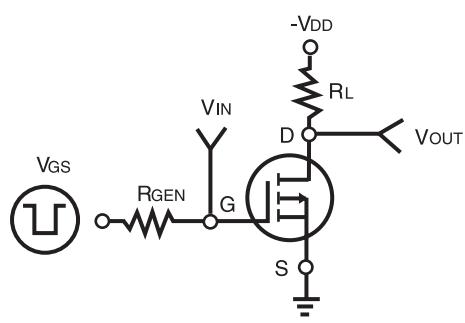


Figure 11. Switching Test Circuit

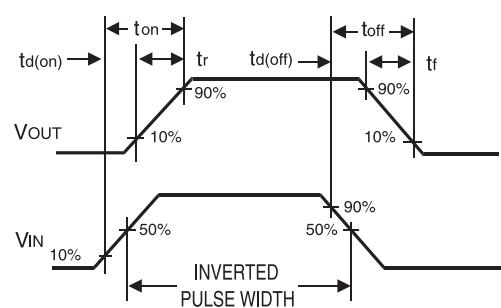


Figure 12. Switching Waveforms

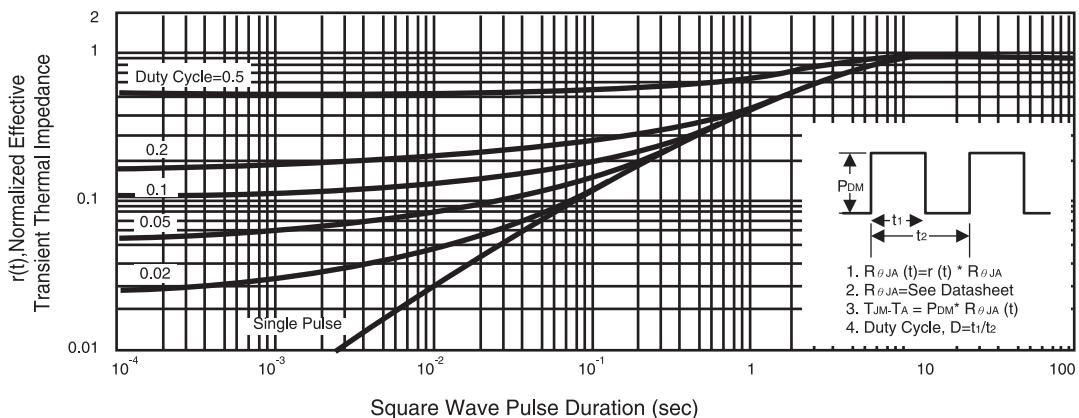


Figure 13. Normalized Thermal Transient Impedance Curve